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FEATURES

- 50 Mbps to 3.3 Gbps operation
- Single 3.3 V operation
- Typical rise/fall time: 80 ps
- Bias current range: 2 mA to 100 mA
- Modulation current range: 5 mA to 80 mA
- Monitor photodiode current: 50 μ A to 1200 μ A
- Dual MPD functionality for DWDM
- 50 mA supply current at 3.3 V
- Closed-loop control of power and extinction ratio
- Full current parameter monitoring
- Laser fail and laser degrade alarms
- Automatic laser shutdown (ALS)
- Optional clocked data
- Supports FEC rates
- 48-lead (7 mm \times 7 mm) LFCSP package
- 32-lead (5 mm \times 5 mm) LFCSP package

APPLICATIONS

- SONET OC-1/3/12/48
- SDH STM-0/1/4/16
- Fibre Channel
- Gigabit Ethernet
- DWDM dual MPD wavelength control

GENERAL DESCRIPTION

The ADN2847 uses a unique control algorithm to control both average power and extinction ratio of the laser diode (LD) after initial factory setup. External component count and PCB area are low, as both power and extinction ratio control are fully integrated. Programmable alarms are provided for laser fail (end of life) and laser degrade (impending fail).

Optional dual MPD current monitoring is designed into the ADN2847 specifically for DWDM wavelength control.

The ADN2847 is specified for the -40°C to $+85^{\circ}\text{C}$ temperature range and is available in a 48-lead LFCSP package and a 32-lead LFCSP package.

FUNCTIONAL BLOCK DIAGRAM

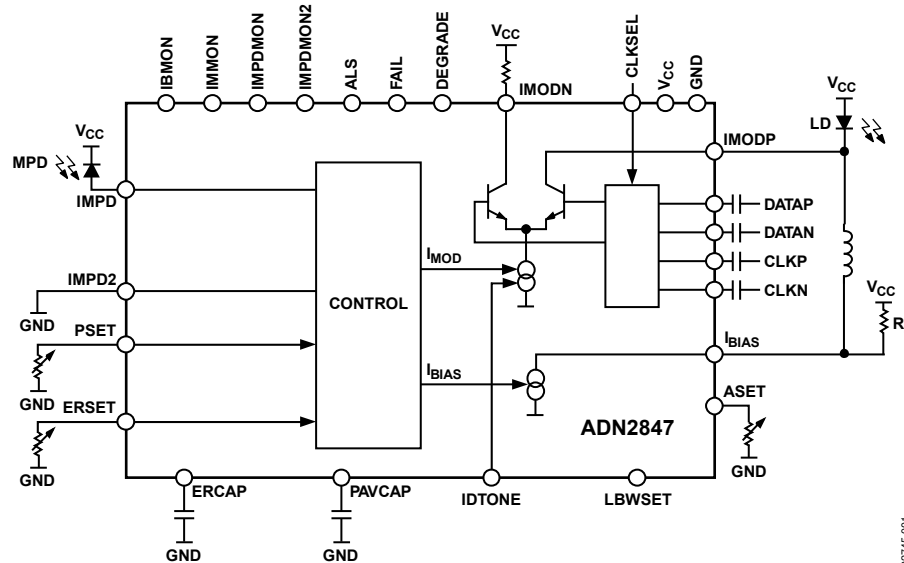


Figure 1.

Rev. B

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ADN2847* PRODUCT PAGE QUICK LINKS

Last Content Update: 02/23/2017

COMPARABLE PARTS

View a parametric search of comparable parts.

EVALUATION KITS

- ADN2847 Evaluation Board

DOCUMENTATION

Application Notes

- AN-631: ADN2841/ADN2847 DC-Coupled Optical Evaluation Kit
- AN-638: ADN2847 AC-Coupled Optical Evaluation Kit
- AN-654: Optical Module Development Platform 2.5 Gbps Transmitter with Digital Diagnostics
- AN-658: Optical Channel Identification on the ADN284x Laser Drivers (Part I)

Data Sheet

- ADN2847: 3V Dual Loop 50 Mbps to 3.3 Gbps Laser Diode Driver Data Sheet

REFERENCE MATERIALS

Informational

- Optical and High Speed Networking ICs

Technical Articles

- Dual-Loop Laser Drivers Bring Robustness To Optical Networks

DESIGN RESOURCES

- ADN2847 Material Declaration
- PCN-PDN Information
- Quality And Reliability
- Symbols and Footprints

DISCUSSIONS

View all ADN2847 EngineerZone Discussions.

SAMPLE AND BUY

Visit the product page to see pricing options.

TECHNICAL SUPPORT

Submit a technical question or find your regional support number.

DOCUMENT FEEDBACK

Submit feedback for this data sheet.

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REVISION HISTORY

3/12—Rev. A to Rev. B

| | |
|----------------------------------|----|
| Added EPAD Notation | 7 |
| Updated Outline Dimensions | 14 |
| Changes to Ordering Guide | 15 |

10/06—Rev. 0 to Rev. A

| | |
|---|-----------|
| Updated Format..... | Universal |
| Change to Data Sheet Title..... | 1 |
| Changes to Figure 1 | 1 |
| Changes to Specifications | 3 |
| Added I _{BIAS} Section | 10 |
| Changes to Laser Diode Interfacing Section..... | 11 |
| Changes to Figure 14..... | 12 |
| Changes to Figure 15..... | 13 |
| Changes to Ordering Guide | 15 |

1/03—Revision 0: Initial Version

SPECIFICATIONS

$V_{CC} = 3.0\text{ V to }3.6\text{ V}$. Temperature range: $-40^{\circ}\text{C to }+85^{\circ}\text{C}$. All specifications T_{MIN} to T_{MAX} , unless otherwise noted. Typical values specified at $T_A = 25^{\circ}\text{C}$.

Table 1.

| Parameter | Min | Typ | Max | Unit | Conditions/Comments |
|---|------|----------------|----------|---------------|---|
| LASER BIAS CURRENT (I_{BIAS} , ALS) | | | | | |
| Output Current I_{BIAS} | 2 | | 100 | mA | $I_{BIAS} < 10\%$ of nominal |
| I_{BIAS} when ALS is asserted | | | 0.1 | mA | |
| ALS Assertion Time | | | 5 | μs | |
| I_{BIAS} Compliance Voltage | 1.2 | | V_{CC} | V | |
| CCBIAS Compliance Voltage | 1.2 | | V_{CC} | V | |
| MODULATION CURRENT (I_{MODP} , I_{MODN}) ¹ | | | | | |
| Output Current I_{MOD} | 5 | | 80 | mA | See Figure 3 for device rise time histogram See Figure 4 for device fall time histogram RMS $I_{MOD} = 40\text{ mA}$ |
| Compliance Voltage | 1.5 | | V_{CC} | V | |
| I_{MOD} when ALS is Asserted | | | 0.1 | mA | |
| Rise Time ² | | 80 | 120 | ps | |
| Fall Time ² | | 80 | 120 | ps | |
| Random Jitter ² | | 1 | 1.5 | ps | |
| Pulse Width Distortion ² | | 15 | | ps | |
| MONITOR PD (MPD, MPD2) | | | | | |
| Current | 50 | | 1200 | μA | Average current |
| Compliance Voltage | | | 1.65 | V | |
| POWER SET INPUT (PSET) | | | | | |
| Capacitance | | | 80 | pF | Average current |
| Monitor Photodiode Current into RPSET Resistor | 50 | | 1200 | μA | |
| Voltage | 1.1 | 1.2 | 1.3 | V | |
| EXTINCTION RATIO SET INPUT (ERSET) | | | | | |
| Allowable Resistance Range | 1.2 | | 25 | k Ω | |
| Voltage | 1.1 | 1.2 | 1.3 | V | |
| ALARM SET (ASET) | | | | | |
| Allowable Resistance Range | 1.2 | | 25 | k Ω | |
| Voltage | 1.1 | 1.2 | 1.3 | V | |
| Hysteresis | | 5 | | % | |
| CONTROL LOOP | | | | | Low Loop Bandwidth selection |
| Time Constant | | 0.22 | | sec | LBWSET = GND |
| | | 2.25 | | sec | LBWSET = V_{CC} |
| DATA INPUTS (DATAP, DATAN, CLKP, CLKN) ³ | | | | | |
| V p-p (Single-Ended, Peak-to-Peak) | 100 | | 500 | mV | Data and clock inputs are ac-coupled |
| Input Impedance (Single-Ended) | | 50 | | Ω | |
| t_{SETUP} ⁴ | 50 | | | ps | See Figure 2 |
| t_{HOLD} ⁴ | 100 | | | ps | See Figure 2 |
| LOGIC INPUTS (ALS, LBWSET, CLKSEL) | | | | | |
| V_{IH} | 2.4 | | | V | |
| V_{IL} | | | 0.8 | V | |
| ALARM OUTPUTS (FAIL, DEGRADE) | | | | | Internal 30 k Ω Pull-Up |
| V_{OH} | 2.4 | | | V | |
| V_{OL} | | | 0.8 | V | |
| IDTONE | | | | | User to supply current sink in the range of 50 μA to 4 mA |
| Compliance Voltage | | $V_{CC} - 1.5$ | | V | |
| I_{OUT}/I_{IN} Ratio | | 2 | | | |
| f_{IN} ⁵ | 0.01 | | 1 | MHz | |

| Parameter | Min | Typ | Max | Unit | Conditions/Comments |
|---------------------------------|-----|-----|----------------|------|--------------------------|
| IBMON, IMMON, IMPDMON, IMPDMON2 | | | | | |
| IBMON, IMMON Division Ratio | | 100 | | A/A | $I_{MPD} = 1200 \mu A$ |
| IMPDMON, IMPDMON2 | | 1 | | A/A | |
| IMPDMON to IMPDMON2 Matching | | | 2 | % | |
| Compliance Voltage | 0 | | $V_{CC} - 1.2$ | V | |
| SUPPLY | | | | | |
| I_{CC}^6 | | 50 | | mA | $I_{BIAS} = I_{MOD} = 0$ |
| V_{CC}^7 | 3.0 | 3.3 | 3.6 | V | |

¹ The high speed performance for the die version of ADN2847 can be achieved when using the bonding diagram shown in Figure 6.

² Measured into a 25 Ω load using a 11110000 pattern at 2.5 Gbps.

³ When the voltage on DATAP is greater than the voltage on DATAN, the modulation current flows in the IMODP pin.

⁴ Guaranteed by design and characterization. Not production tested.

⁵ IDTONE can cause eye distortion.

⁶ I_{CCMIN} for power calculation in the Power Consumption section is the typical I_{CC} given.

⁷ All V_{CC} pins should be shorted together.

TIMING DIAGRAMS

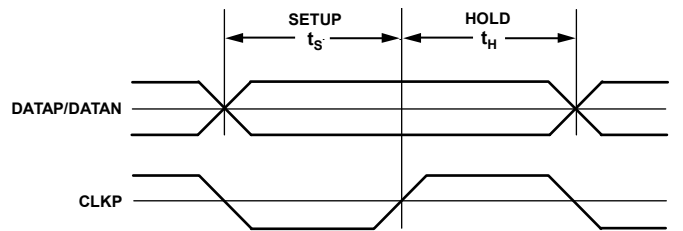


Figure 2. Setup and Hold Time

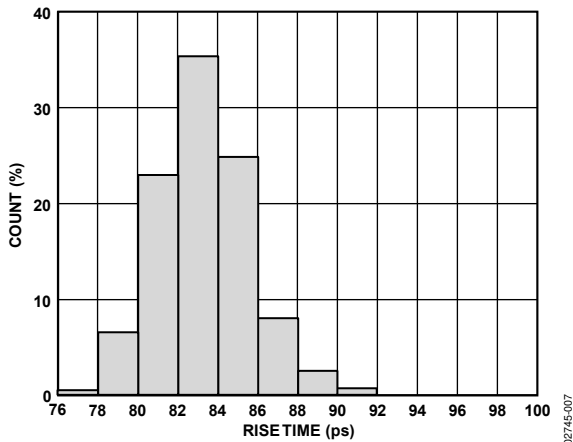


Figure 3. Rise Time Distribution Under Worst-Case Operating Conditions

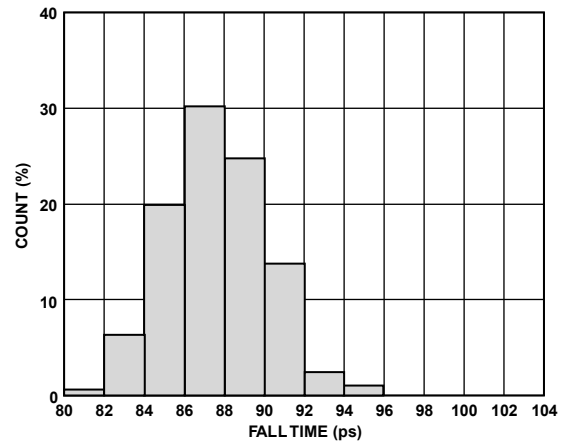


Figure 4. Fall Time Distribution Under Worst-Case Operating Conditions

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 2.

| Parameter | Rating |
|--|---|
| V_{CC} to GND | 4.2 V |
| Digital Inputs (ALS, LBWSET, CLKSEL) | $-0.3\text{ V to }V_{CC} + 0.3\text{ V}$ |
| IMODN, IMODP | $V_{CC} + 1.2\text{ V}$ |
| Operating Temperature Range Industrial | $-40^\circ\text{C to }+85^\circ\text{C}$ |
| Storage Temperature Range | $-65^\circ\text{C to }+150^\circ\text{C}$ |
| Junction Temperature (T_J max) | 150°C |
| Power Dissipation ¹ (W) | $(T_J \text{ max} - T_A) / \theta_{JA}$ |
| Lead Temperature (Soldering 10 sec) | 300°C |

¹ Power consumption formulae are provided in the Power Consumption section.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

θ_{JA} is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages.

Table 3. Thermal Resistance

| Package Type | θ_{JA} | Unit |
|---------------|---------------|--------------------|
| 48-lead LFCSP | 25 | $^\circ\text{C/W}$ |
| 32-lead LFCSP | 32 | $^\circ\text{C/W}$ |

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

DIE PAD COORDINATES

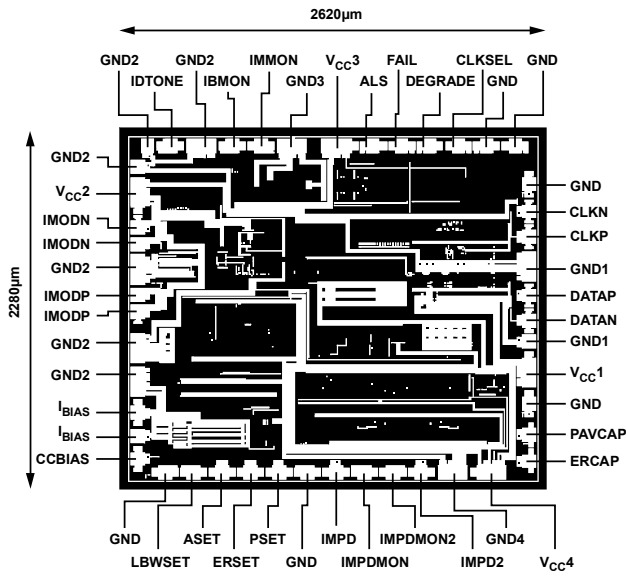


Figure 5. Metallization Photograph

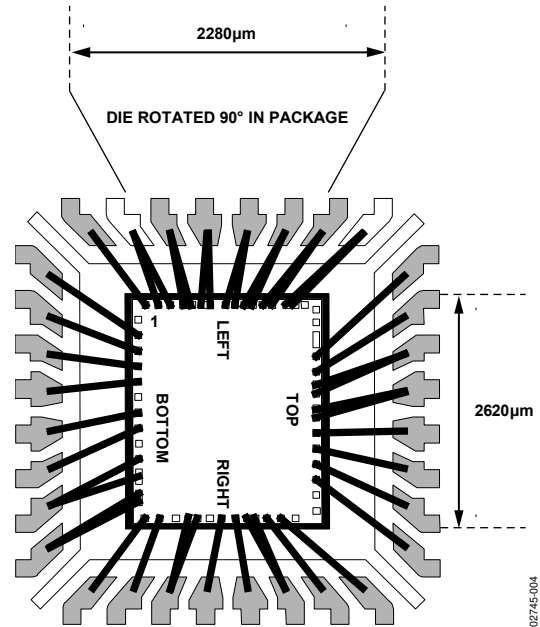


Figure 6. Bonding Diagram

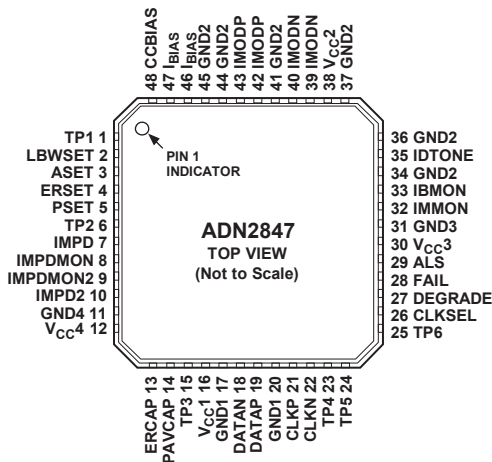
Table 4. Die Pad Coordinates¹

| Pad Number | Pad Name | x[µm] | y[µm] |
|------------|-------------------|-------|-------|
| 1 | TP1 (GND) | -996 | 1026 |
| 2 | LBWSET | -996 | 853 |
| 3 | ASET | -996 | 679 |
| 4 | ERSET | -996 | 506 |
| 5 | PSET | -996 | 332 |
| 6 | TP2 (GND) | -996 | 159 |
| 7 | IMPD | -996 | -15 |
| 8 | IMPDMON | -996 | 506 |
| 9 | IMPDMON2 | -996 | -361 |
| 10 | IMPD2 | -996 | -534 |
| 11 | GND4 | -996 | -724 |
| 12 | V _{cc} 4 | -995 | -964 |
| 13 | ERCAP | -925 | -1191 |
| 14 | PAVCAP | -777 | -1191 |
| 15 | TP3 (GND) | -606 | -1191 |
| 16 | V _{cc} 1 | -389 | -1191 |
| 17 | GND1 | -200 | -1191 |
| 18 | DATAN | -70 | -1191 |
| 19 | DATAP | 83 | -1191 |
| 20 | GND1 | 263 | -1191 |
| 21 | CLKP | 442 | -1191 |
| 22 | CLKN | 596 | -1191 |
| 23 | TP4 (GND) | 762 | -1191 |
| 24 | TP5 (GND) | 996 | -1109 |

| Pad Number | Pad Name | x[µm] | y[µm] |
|------------|-------------------|-------|-------|
| 25 | TP6 (GND) | 996 | -935 |
| 26 | CLKSEL | 996 | -762 |
| 27 | DEGRADE | 996 | -589 |
| 28 | FAIL | 996 | -415 |
| 29 | ALS | 996 | -242 |
| 30 | V _{cc} 3 | 996 | -19 |
| 31 | GND3 | 996 | 251 |
| 32 | IMMON | 996 | 441 |
| 33 | IBMON | 996 | 614 |
| 34 | GND2 | 996 | 804 |
| 35 | IDTONE | 995 | 993 |
| 36 | GND2 | 995 | 1133 |
| 37 | GND2 | 867 | 1191 |
| 38 | V _{cc} 2 | 713 | 1191 |
| 39 | IMODN | 500 | 1191 |
| 40 | IMODN | 396 | 1191 |
| 41 | GND2 | 242 | 1191 |
| 42 | IMODP | 88 | 1191 |
| 43 | IMODP | -16 | 1191 |
| 44 | GND2 | -239 | 1191 |
| 45 | GND2 | -443 | 1191 |
| 46 | I _{BIAS} | -633 | 1191 |
| 47 | I _{BIAS} | -772 | 1191 |
| 48 | CCBIAS | -912 | 1191 |

¹ With the origin in the center of the die (see Figure 5).

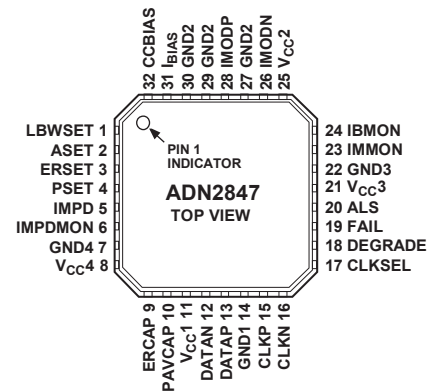
PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



NOTES
1. THE EXPOSED PAD ON THE BOTTOM OF THE PACKAGE MUST BE CONNECTED TO V_{CC} OR THE GND PLANE.

Figure 7. 48-Lead LFCSP

02745-005



NOTES
1. THE EXPOSED PAD ON THE BOTTOM OF THE PACKAGE MUST BE CONNECTED TO V_{CC} OR THE GND PLANE.

Figure 8. 32-Lead LFCSP

02745-006

Table 5. Pin Function Descriptions

| Pin Number | | Mnemonic | Description |
|------------|---------|------------------|---|
| 48-Lead | 32-Lead | | |
| 1 | N/A | TP1 | Test Pin. In normal operation, TP1 = GND. |
| 2 | 1 | LBWSET | Select Low Loop Bandwidth. |
| 3 | 2 | ASET | Alarm Current Threshold Setting Pin. |
| 4 | 3 | ERSET | Extinction Ratio Set Pin. |
| 5 | 4 | PSET | Average Optical Power Set Pin. |
| 6 | N/A | TP2 | Test Pin. In normal operation, TP2 = GND. |
| 7 | 5 | IMPD | Monitor Photodiode Input. |
| 8 | 6 | IMPDMON | Mirrored Current from Monitor Photodiode. |
| 9 | N/A | IMPDMON2 | Mirrored Current from Monitor Photodiode 2. (For use with two MPDs). |
| 10 | N/A | IMPD2 | Monitor Photodiode Input 2. (For use with two MPDs). |
| 11 | 7 | GND4 | Supply Ground. |
| 12 | 8 | V _{CC4} | Supply Voltage. |
| 13 | 9 | ERCAP | Extinction Ratio Loop Capacitor. |
| 14 | 10 | PAVCAP | Average Power Loop Capacitor. |
| 15 | N/A | TP3 | Test Pin. In normal operation, TP3 = GND. |
| 16 | 11 | V _{CC1} | Supply Voltage. |
| 17 | N/A | GND1 | Supply Ground. |
| 18 | 12 | DATAN | Data, Negative Differential Terminal. |
| 19 | 13 | DATAP | Data, Positive Differential Terminal. |
| 20 | 14 | GND1 | Supply Ground. |
| 21 | 15 | CLKP | Data Clock Positive Differential Terminal. Used if CLKSEL = V _{CC} . |
| 22 | 16 | CLKN | Data Clock Negative Differential Terminal. Used if CLKSEL = V _{CC} . |
| 23 | N/A | TP4 | Test Pin. In normal operation, TP4 = GND. |
| 24 | N/A | TP5 | Test Pin. In normal operation, TP5 = GND. |
| 25 | N/A | TP6 | Test Pin. In normal operation, TP6 = GND. |
| 26 | 17 | CLKSEL | Clock Select. Active = V _{CC} . Used if data is clocked into chip. |
| 27 | 18 | DEGRADE | Degrade Alarm Output. |
| 28 | 19 | FAIL | Fail Alarm Output. |
| 29 | 20 | ALS | Automatic Laser Shutdown. |

| Pin Number | | Mnemonic | Description |
|------------|---------|-------------------|---|
| 48-Lead | 32-Lead | | |
| 30 | 21 | V _{CC3} | Supply Voltage. |
| 31 | 22 | GND3 | Supply Ground. |
| 32 | 23 | IMMON | Modulation Current Mirror Output. |
| 33 | 24 | IBMON | Bias Current Mirror Output. |
| 34 | N/A | GND2 | Supply Ground. |
| 35 | N/A | IDTONE | IDTONE. Requires external current sink to ground. |
| 36 | N/A | GND2 | Supply Ground. |
| 37 | N/A | GND2 | Supply Ground. |
| 38 | 25 | V _{CC2} | Supply Voltage. |
| 39 | 26 | IMODN | Modulation Current Negative Output. Connect via a matching resistor to V _{CC} . |
| 40 | N/A | IMODN | Modulation Current Negative Output. Connect via a matching resistor to V _{CC} . |
| 41 | 27 | GND2 | Supply Ground. |
| 42 | 28 | IMODP | Modulation Current Positive Output. Connect to laser diode. |
| 43 | N/A | IMODP | Modulation Current Positive Output. Connect to laser diode. |
| 44 | 29 | GND2 | Supply Ground. |
| 45 | 30 | GND2 | Supply Ground. |
| 46 | 31 | I _{BIAS} | Laser Diode Bias Current. |
| 47 | N/A | I _{BIAS} | Laser Diode Bias Current. |
| 48 | 32 | CCBIAS | Extra Laser Diode Bias. (Connected to V _{CC} when dc-coupled to laser diode. Connected to I _{BIAS} when ac-coupled to laser diode). |
| EP | EP | EPAD | Exposed Pad. The exposed pad on the bottom of the package must be connected to V _{CC} or the GND plane. |

THEORY OF OPERATION

Laser diodes have current-in to light-out transfer functions, as shown in Figure 9. Two key characteristics of this transfer function are the threshold current, I_{TH} , and the slope in the linear region beyond the threshold current, referred to as slope efficiency (LI).

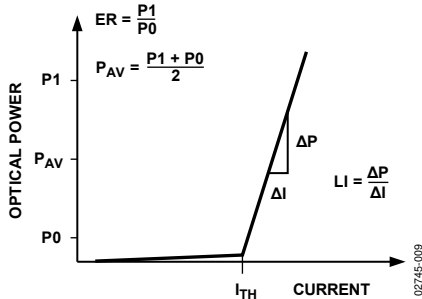


Figure 9. Laser Transfer Function

CONTROL

A monitor photodiode (MPD) is required to control the LD. The MPD current is fed into the ADN2847 to control the power and extinction ratio, continuously adjusting the bias current and modulation current in response to the changing threshold current and light-to-current slope efficiency of the laser.

The ADN2847 uses automatic power control (APC) to maintain a constant average power over time and temperature.

The ADN2847 uses closed-loop extinction ratio control to allow optimum setting of the extinction ratio for every device. Thus, SONET/SDH interface standards can be met over device variation, temperature, and laser aging. Closed-loop modulation control eliminates the need to either overmodulate the LD or include external components for temperature compensation. This reduces research and development time and second sourcing issues caused by characterizing LDs.

Average power and extinction ratio are set using the PSET pin and the ERSET pin, respectively. Potentiometers are connected between these pins and ground. The potentiometer R_{PSET} is used to change the average power. The potentiometer R_{ERSET} is used to adjust the extinction ratio. Both PSET and ERSET are kept 1.2 V above GND.

The R_{PSET} and R_{ERSET} potentiometers can be calculated using the following formulas:

$$R_{PSET} = \frac{1.2 \text{ V}}{I_{AV}} (\Omega)$$

$$R_{ERSET} = \frac{1.2 \text{ V}}{\frac{I_{MPD_CW}}{P_{CW}} \times \frac{ER - 1}{ER + 1} \times P_{AV}} (\Omega)$$

where:

I_{AV} is the average MPD current.

P_{CW} is the dc optical power specified on the laser data sheet.

I_{MPD_CW} is the MPD current at that specified P_{CW} .

P_{AV} is the average power required.

ER is the desired extinction ratio ($ER = P1/P0$).

Note that I_{ERSET} and I_{PSET} changes from device to device; however, the control loops determines actual values. It is not required to know exact values for LI or MPD optical coupling.

LOOP BANDWIDTH SELECTION

For continuous operation, the user should hardwire the LBWSET pin high and use 1 μF capacitors to set the actual loop bandwidth. These capacitors are placed between the PAVCAP pin and the ERCAP pin and ground. It is important that these capacitors are low leakage multilayer ceramics with an insulation resistance greater than 100 G Ω or a time constant of 1000 seconds, whichever is less.

Table 6.

| Operation Mode | LBWSET | Recommended PAVCAP | Recommended ERCAP |
|--|--------|--------------------|-------------------|
| Continuous 50 Mbps to 3.3 Gbps | High | 1 μF | 1 μF |
| Optimized for 2.5 Gbps to 3.3 Gbps | Low | 22 nF | 22 nF |

Setting LBSET low and using 22 nF capacitors results in a shorter loop time constant (a 10 \times reduction over using 1 μF capacitors and keeping LBWSET high.)

ALARMS

The ADN2847 is designed to allow interface compliance to ITUT-G958 (11/94) section 10.3.1.1.2 (transmitter fail) and section 10.3.1.1.3 (transmitter degrade). The ADN2847 has two active high alarms, DEGRADE and FAIL. A resistor between ground and the ASET pin is used to set the current at which these alarms are raised. The current through the ASET resistor is a ratio of 100:1 to the FAIL alarm threshold. The DEGRADE alarm is raised at 90% of this level.

Example:

$$I_{FAIL} = 50 \text{ mA so } I_{DEGRADE} = 45 \text{ mA}$$

$$I_{ASET} = \frac{I_{FAIL}}{100} = \frac{50 \text{ mA}}{100} = 500 \mu\text{A}$$

$$R_{ASET} = \frac{1.2 \text{ V}}{I_{ASET}} = \frac{1.2}{500 \mu\text{A}} = 2.4 \text{ k}\Omega$$

where the smallest valid value for R_{ASET} is 1.2 k Ω , because this corresponds to the I_{BIAS} maximum of 100 mA.

The laser degrade alarm, DEGRADE, is provided to give a warning of imminent laser failure if the laser diode degrades further or environmental conditions continue to stress the LD, such as increasing temperature.

The laser fail alarm, FAIL, is activated when the transmitter can no longer be guaranteed to be SONET/SDH compliant. This occurs when one of the following conditions arises:

- The ASET threshold is reached.
- The ALS pin is set high. This shuts off the modulation and bias currents to the LD, resulting in the MPD current dropping to zero. This gives closed-loop feedback to the system that ALS has been enabled.

DEGRADE is raised only when the bias current exceeds 90% of ASET current.

MONITOR CURRENTS

IBMON, IMMON, IMPDMON, and IMPDMON2 are current controlled current sources from V_{CC} . They mirror the bias, modulation, and MPD current for increased monitoring functionality. An external resistor to GND gives a voltage proportional to the current monitored.

If the monitoring functions IMPDMON and IMPDMON2 are not required, the IMPD pin and the IMPD2 pin must be grounded and the monitor photodiode output must be connected directly to the PSET pin.

DUAL MPD DWDM FUNCTION (48-LEAD LFCSP ONLY)

The ADN2847 has circuitry for a second monitor photodiode, MPD2. The second photodiode current is mirrored to IMPDMON2 for wavelength control purposes and is summed internally with the first monitor photodiode current for the power control loop. For single MPD circuits, the MPD2 pin is tied to GND.

This enables the system designer to use the two currents to control the wavelength of the laser diode using various optical filtering techniques inside the laser module.

If the monitor current functions IMPDMON and IMPDMON2 are not required, then the IMPD pin and IMPD2 pin can be grounded and the monitor photodiode output can be connected directly to PSET.

IDTONE (48-LEAD LFCSP ONLY)

The IDTONE pin is supplied for fiber identification/supervisory channels or control purposes in WDM. This pin modulates the optical one level over a possible range of 2% of minimum I_{MOD} to 10% of maximum I_{MOD} . The level of modulation is set by connecting an external current sink between the IDTONE pin and ground. There is a gain of two from this pin to the I_{MOD} current. Figure 12 shows how the AD9850/AD9851 or the AD9834 can be used with the ADN2847 to allow fiber identification.

If the ID_TONE function is not used, the IDTONE pin should be tied to V_{CC} . Note that using IDTONE during transmission can cause optical eye degradation.

DATA AND CLOCK INPUTS

Data and clock inputs are ac-coupled (10 nF capacitors are recommended) and terminated via a 100 Ω internal resistor between DATAP and DATAN, and also between the CLKP pin and the CLKN pin. There is a high impedance circuit to set the common-mode voltage that is designed to allow for maximum input voltage headroom over temperature. It is necessary that ac coupling is used to eliminate the need for matching between common-mode voltages.

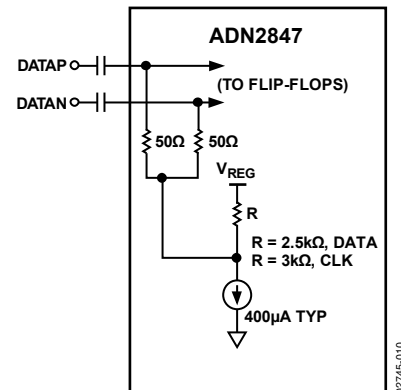
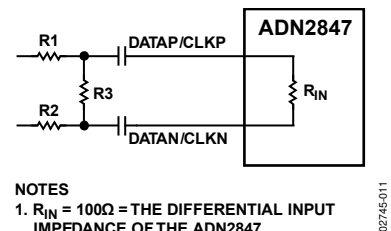


Figure 10. AC Coupling of Data Inputs

For input signals that exceed 500 mV p-p single-ended, it is necessary to insert an attenuation circuit as shown in Figure 11.



NOTES
1. $R_{IN} = 100\Omega$ = THE DIFFERENTIAL INPUT IMPEDANCE OF THE ADN2847.

Figure 11. Attenuation Circuit

CCBIAS

When the laser is used in ac-coupled mode, the CCBIAS pin and the I_{BIAS} pin should be tied together (Figure 15). In dc-coupled mode, CCBIAS should be tied to V_{CC} .

I_{BIAS}

To achieve optimum eye quality, one pull-up resistor (R_Z) is necessary, as shown in both circuits in Figure 14 and Figure 15. The recommended resistor R_Z value is approximately 200 Ω ~ 500 Ω .

AUTOMATIC LASER SHUTDOWN

The ADN2847 ALS allows compliance to ITU-T-G958 (11/94), section 9.7. When ALS is logic high, both bias and modulation currents are turned off. Correct operation of ALS can be confirmed if the FAIL alarm is raised when ALS is asserted. Note that this is the only time DEGRADE is low while FAIL is high.

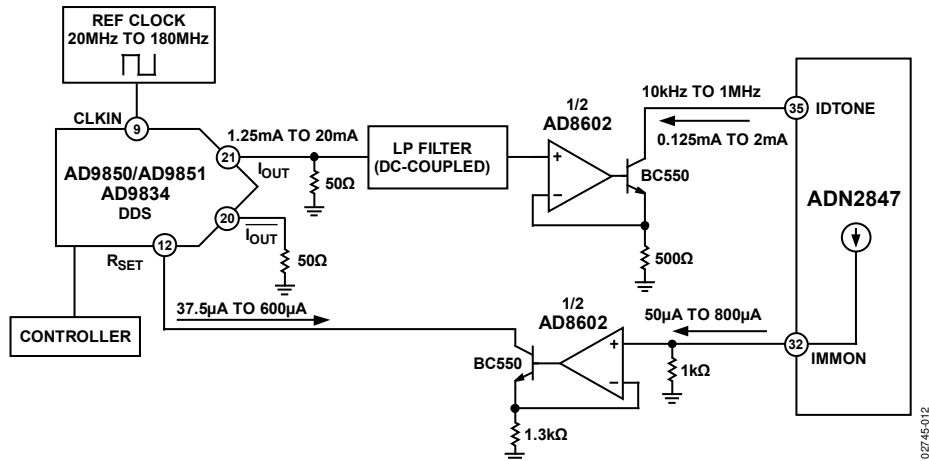


Figure 12. Application Circuit to Allow Fiber Identification Using the AD9850/AD9851

ALARM INTERFACES

The FAIL and DEGRADE outputs have an internal pull-up resistor of 30 kΩ, used to pull the digital high value to V_{CC}. However, the alarm can be overdriven with an external resistor allowing alarm interfacing to non-V_{CC} levels. Non-V_{CC} alarm output levels must be below the V_{CC} used for the ADN2847.

POWER CONSUMPTION

The ADN2847 die temperature must be kept below 125°C. Both LFCSP packages have an exposed paddle that should be connected in such a manner that is at the same potential as the ADN2847 ground pins. The θ_{JA} for both packages is specified in the Absolute Maximum Ratings section. Power consumption can be calculated using

$$I_{CC} = I_{CCMIN} + 0.3 I_{MOD}$$

$$P = V_{CC} \times I_{CC} + (I_{BIAS} \times V_{BIAS_PIN}) + I_{MOD} (V_{MODP_PIN} + V_{MODN_PIN})/2$$

$$T_{DIE} = T_{AMBIENT} + \theta_{JA} \times P$$

Thus, the maximum combination of I_{BIAS} + I_{MOD} must be calculated, where:

I_{CCMIN} = 50 mA (typical value of I_{CC} provided in the Specifications section)

$$I_{BIAS} = I_{MOD} = 0$$

T_{DIE} = die temperature

T_{AMBIENT} = ambient temperature

V_{BIAS_PIN} = voltage at I_{BIAS} pin

V_{MODP_PIN} = average voltage at IMODP pin

V_{MODN_PIN} = average voltage at IMODN pin

LASER DIODE INTERFACING

Many laser diodes designed for 2.5 Gbps operation are packaged with an internal resistor to bring the effective impedance up to 25 Ω to minimize transmission line effects. In high current applications, the voltage drop across this resistor combined with the laser diode forward voltage makes direct connection between the laser and the driver impractical in a 3 V system.

AC coupling the driver to the laser diode removes this headroom constraint.

Caution must be taken when choosing component values for ac coupling (see Figure 15) to ensure that the time constants (L/R and RC) are sufficiently long for the data rate and expected number of consecutive identical digits (CIDs). Failure to do this can lead to pattern dependent jitter and vertical eye closure.

For designs with low series resistance, or where external components become impractical, the ADN2847 supports direct connection to the laser diode (see Figure 14). In this case, care must be taken to ensure that the voltage drop across the laser diode does not violate the minimum compliance voltage on the IMODP pin.

OPTICAL SUPERVISOR

The PSET and ERSET potentiometers can be replaced with a dual-digital potentiometer, the ADN2850 (see Figure 13). The ADN2850 provides an accurate digital control for the average optical power and extinction ratio and ensures excellent stability over temperature.

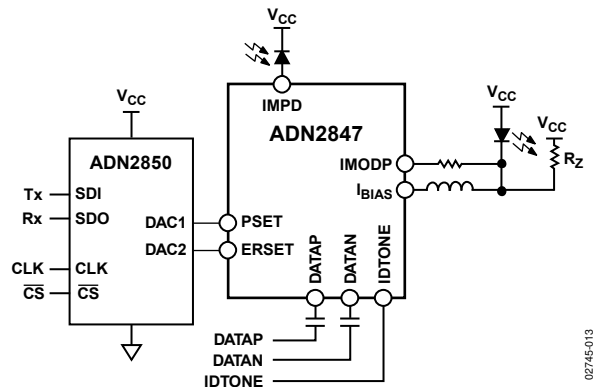
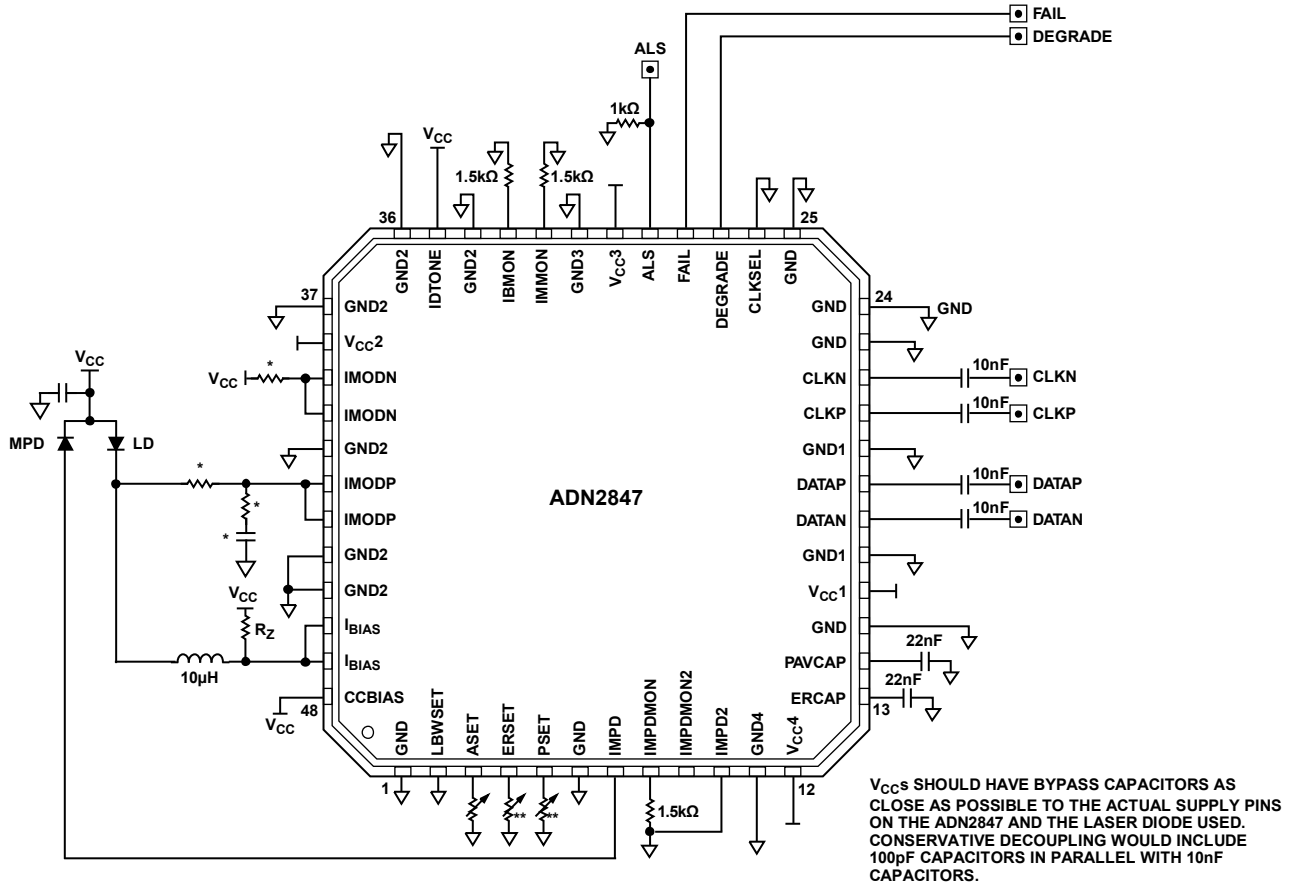
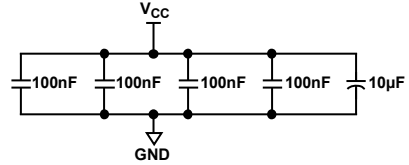


Figure 13. Application Using the ADN2850 a Dual 10-Bit Digital Potentiometer with an Extremely Low Temperature Coefficient as an Optical Supervisor



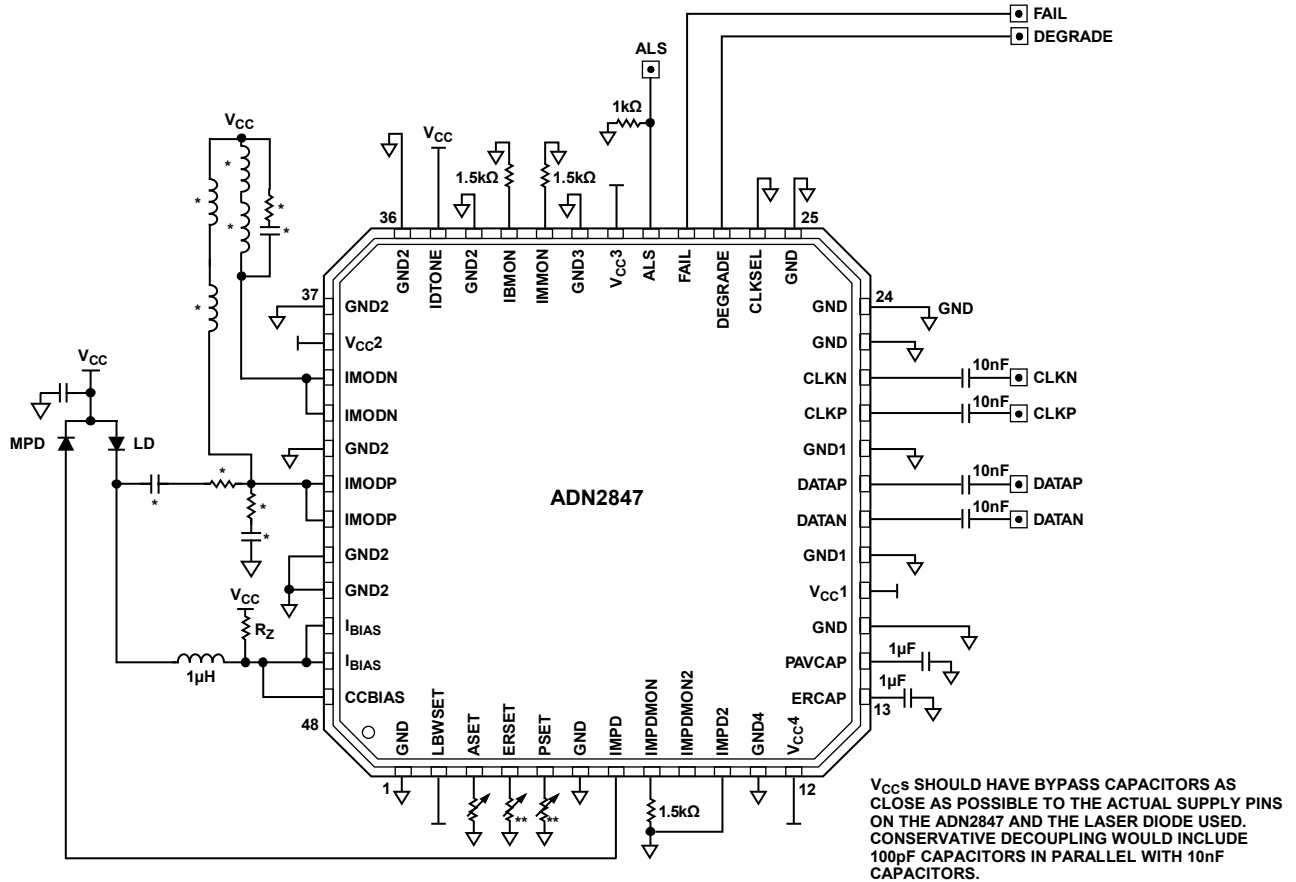
LD = LASER DIODE
MPD = MONITOR PHOTODIODE



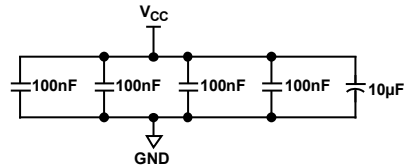
- NOTES**
- * DESIGNATES COMPONENTS THAT NEED TO BE OPTIMIZED FOR THE TYPE OF LASER USED.
 - ** FOR DIGITAL PROGRAMMING, THE ADN2850 OR THE ADN2860 OPTICAL SUPERVISOR CAN BE USED.

Figure 14. DC-Coupled 3.3 Gbps Test Circuit, Data Not Clocked

02745-014



LD = LASER DIODE
MPD = MONITOR PHOTODIODE



- NOTES**
 * DESIGNATES COMPONENTS THAT NEED TO BE OPTIMIZED FOR THE TYPE OF LASER USED.
 ** FOR DIGITAL PROGRAMMING, THE ADN2850 OR THE ADN2860 OPTICAL SUPERVISOR CAN BE USED.

Figure 15. AC-Coupled 50 Mbps to 3.3 Gbps Test Circuit, Data Not Clocked

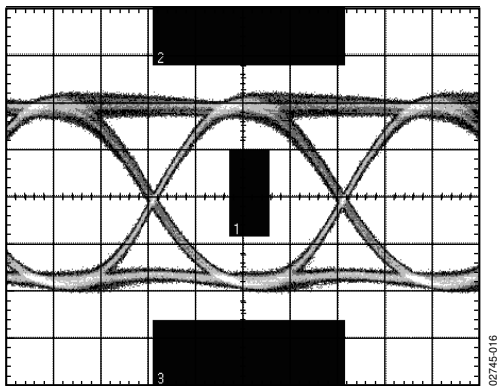


Figure 16. 2.5 Gbps Optical Eye at 25°C. Average Power = 0 dBm, Extinction Ratio = 10 dB, PRBS 31 Pattern. Eye Obtained Using a DFB Laser.

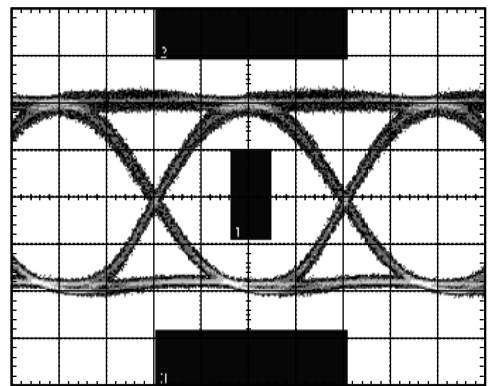
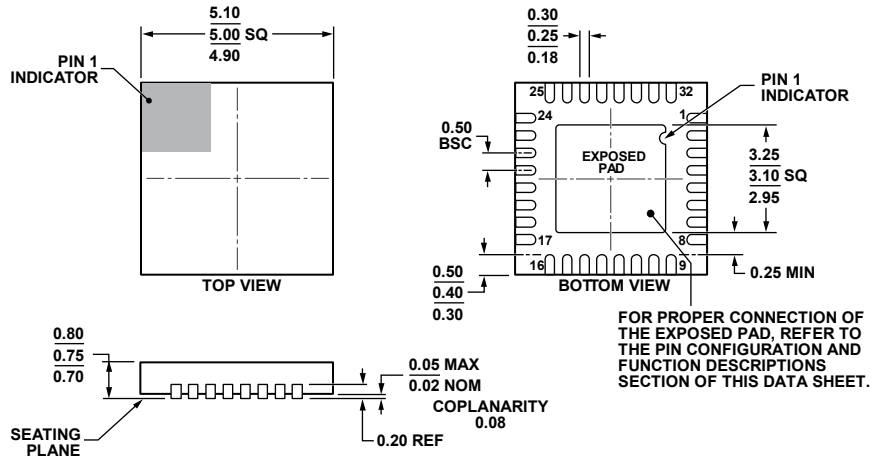


Figure 17. 2.5 Gbps Optical Eye at 85°C. Average Power = 0 dBm, Extinction Ratio = 10 dB, PRBS 31 Pattern. Eye Obtained Using a DFB Laser.

OUTLINE DIMENSIONS

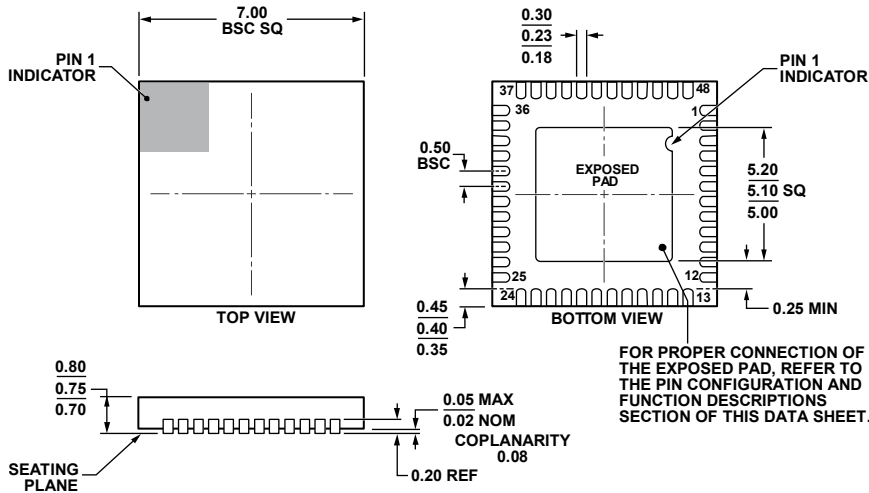


COMPLIANT TO JEDEC STANDARDS MO-220-WHHD.

Figure 18. 32-Lead Lead Frame Chip Scale Package [LFCSP_WQ]
5 mm × 5 mm Body, Very Very Thin Quad
(CP-32-7)

Dimensions shown in millimeters

112408-A



COMPLIANT TO JEDEC STANDARDS MO-220-WKDD.

Figure 19. 48-Lead Lead Frame Chip Scale Package [LFCSP_WQ]
7 mm × 7 mm Body, Very Very Thin Quad
(CP-48-4)

Dimensions shown in millimeters

112408-B

ORDERING GUIDE

| Model¹ | Temperature Range | Package Description | Package Option |
|--------------------------|--------------------------|--|-----------------------|
| ADN2847ACPZ-32 | -40°C to +85°C | 32-Lead Lead Frame Chip Scale Package [LFCSP_WQ] | CP-32-7 |
| ADN2847ACPZ-32-RL | -40°C to +85°C | 32-Lead Lead Frame Chip Scale Package [LFCSP_WQ] | CP-32-7 |
| ADN2847ACPZ-32-RL7 | -40°C to +85°C | 32-Lead Lead Frame Chip Scale Package [LFCSP_WQ] | CP-32-7 |
| ADN2847ACPZ-48 | -40°C to +85°C | 48-Lead Lead Frame Chip Scale Package [LFCSP_WQ] | CP-48-4 |

¹ Z = RoHS Compliant Part.

NOTES